

#### **General Description**

The MAX16054 is a pushbutton on/off controller with a single switch debouncer and built-in latch. It accepts a noisy input from a mechanical switch and produces a clean latched digital output after a factory-fixed qualification delay.

The MAX16054 eliminates contact bounce during switch opening and closing. The state of the output changes only when triggered by the falling edge of the debounced switch input; the output remains unchanged on the rising edge of the input. Robust switch inputs handle ±25V levels and are ±15kV ESD protected for use in harsh industrial environments. The MAX16054 features a complementary output, OUT, which is the inverted state of OUT. An asynchronous CLEAR input allows an external signal to force the output flip-flop low. Undervoltage-lockout circuitry ensures that OUT is in the off state upon power-up. The MAX16054 requires no external components, and its low supply current makes it ideal for use in portable equipment.

The MAX16054 operates from a +2.7V to +5.5V single supply. The MAX16054 is offered in a 6-pin thin SOT23 package and operates over the -40°C to +125°C automotive temperature range.

## **Applications**

**PDAs** 

MP3/Video Players

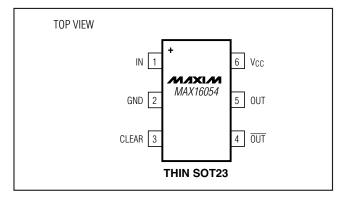
Portable Electronics

**Set-Top Boxes** 

Portable Instrumentation

White Goods

## Pin Configuration



#### Features

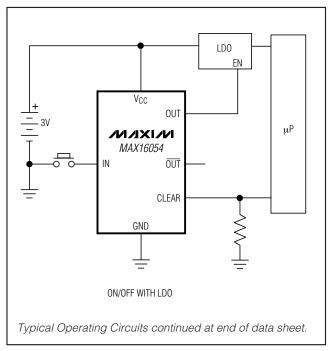
- ♦ Robust Inputs Can Handle Power Supplies Up to ±25V
- ♦ ±15kV ESD Protection
- **♦ Latched Output**
- ♦ Low 7µA Supply Current
- ♦ Operates from 2.7V to 5.5V
- ♦ -40°C to +125°C Temperature Range
- ♦ Thin SOT23 Package

### **Ordering Information**

PART	TEMP RANGE	PIN- PACKAGE	TOP MARK
MAX16054AZT+T	-40°C to +125°C	6 Thin SOT23	+AADU

<sup>+</sup>Denotes a lead-free package.

## **Typical Operating Circuits**



T = Tape and reel package. Devices are offered in 2.5k unit increments.

#### **ABSOLUTE MAXIMUM RATINGS**

V <sub>CC</sub> to GND	0.3V to +6V	Continuous Power Dissipation ( $T_A = +70^{\circ}C$ )	
IN to GND	30V to +30V	6-Pin Thin SOT23	
CLEAR to GND	0.3V to +6V	(derate 9.1mW/°C at +70°C) (Note 1)	727mW
OUT, OUT to GND	0.3V to (V <sub>CC</sub> + 0.3V)	Operating Temperature Range	40°C to +125°C
Short-Circuit Duration	,	Maximum Junction Temperature	
OUT, OUT to GND	Continuous	Storage Temperature Range	60°C to +150°C
		Lead Temperature (soldering, 10s)	+300°C

Note 1: As per JEDEC 51 standard, multilayer board (PCB).

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### **ELECTRICAL CHARACTERISTICS**

 $(V_{CC} = +2.7 \text{V to } +5.5 \text{V}, T_A = T_J = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}, \text{ unless otherwise noted.}$  Typical values are at  $V_{CC} = +5 \text{V}, T_A = +25 ^{\circ}\text{C}.)$  (Note 2)

PARAMETER	SYMBOL	CON	DITIONS	MIN	TYP	MAX	UNITS
Operating Voltage Range	Vcc	(Note 3)		2.7		5.5	V
Supply Current	Icc	V <sub>CC</sub> = 5V, I <sub>OUT</sub> = I <sub>OUT</sub> = 0, IN not connected			7	20	μΑ
D - D -:	t <sub>DP</sub>	T <sub>A</sub> = +25°C		20	50	80	ms
Debounce Duration		$T_A = -40^{\circ}C \text{ to } +125^{\circ}C$		5	50	99	
	V <sub>IL</sub>					0.65	
IN Threshold	Vii i	V <sub>CC</sub> = 5V		2.5			V
	VIH	V <sub>CC</sub> = 2.7V		2.0			
IN Hysteresis					420		mV
IN Pullup Resistance				32	63	100	kΩ
IN Current	lo.	$V_{IN} = +25V$				+1.5	mA
in Current	IIN	V <sub>IN</sub> = -25V		-1.5			IIIA
IN Voltage Range	VIN			-25		+25	V
Undervoltage-Lockout Threshold	V <sub>U</sub> VLO	V <sub>CC</sub> falling			1.8	2.4	V
OUT/OUT Output Voltage	V <sub>OL</sub>	I <sub>SINK</sub> = 1.6mA				0.4	
OO1/OO1 Output voltage	VoH	ISOURCE = 0.4mA		V <sub>C</sub> C - 1.0			V
	VCLEAR_IL					0.7	
CLEAR Threshold	VCLEAR_IH	V <sub>CC</sub> = 5V		2.4			V
		$V_{CC} = 2.7V$		2.0			
CLEAR Input Current	ICLEAR			-1		+1	μΑ
CLEAR High to OUT Low Propagation Delay	tco	$R_L = 10k\Omega$ , $C_L = 100pF$				200	ns
ESD CHARACTERISTICS							
		IN	IEC 61000-4-2 Air Discharge		±15		
ESD Protection			IEC 61000-4-2 Contact Discharge		±8		kV
		Human Body Model			±15		

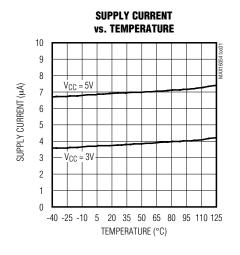
Note 2: All devices are 100% production tested at  $T_A = +25$ °C. Specifications over temperature limits are guaranteed by design.

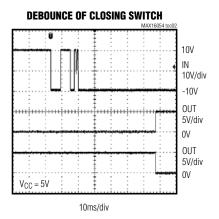
**Note 3:** OUT is guaranteed to be low for  $1.0V \le V_{CC} \le V_{UVLO}$ .

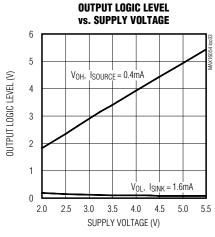


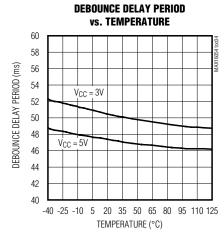
**Typical Operating Characteristics** 

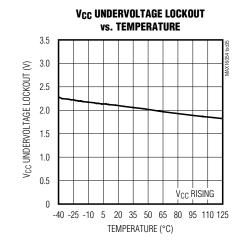
 $(T_A = +25^{\circ}C, \text{ unless otherwise noted.})$ 







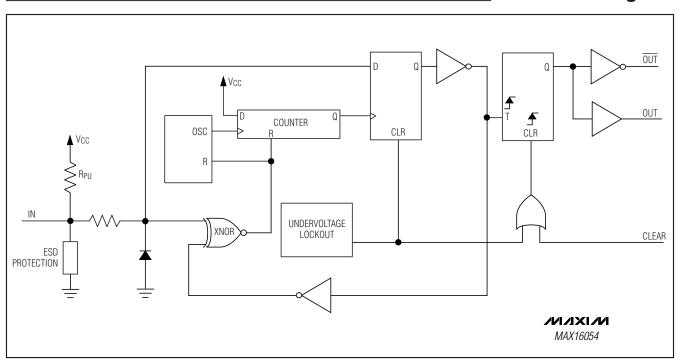




## **Pin Description**

PIN	NAME	FUNCTION	
1	IN	Switch Toggle Input. IN features a -25V to +25V maximum input range and includes an internal $63k\Omega$ pullup resistor to $V_{CC}$ . Connect a pushbutton from IN to GND.	
2	GND	Ground	
3	CLEAR	Clear Input. Pull CLEAR high to force OUT low. Connect CLEAR to GND if unused.	
4	OUT	Active-Low CMOS Output	
5	OUT	Active-High CMOS Output	
6	V <sub>C</sub> C	+2.7V to +5.5V Supply Input. In noisy environments, bypass V <sub>CC</sub> to GND with a 0.1µF or greater ceramic capacitor.	

#### **Functional Diagram**



## **Detailed Description**

#### Theory of Operation

The MAX16054 creates a push-on, push-off function using a momentary-contact normally open SPST switch. The high-to-low transition that occurs when closing the switch causes OUT to go high and OUT to go low. The output state remains latched after the switch is released/opened. Closing the switch again causes OUT to go low and OUT to go high.

Debounce circuitry eliminates the extraneous level changes that result from interfacing with mechanical switches (switch bounce). Virtually all mechanical switches bounce upon opening and closing. The bounce when a switch opens or closes is eliminated by requiring that the sequentially clocked input remains in the same state for a number of sampling periods. The

output does not change state from high-to-low or low-to-high until the input is stable for at least 50ms (typ).

The Functional Diagram shows the functional blocks consisting of an on-chip oscillator, counter, exclusive-NOR gate, a D flip-flop, and a T (toggle) flip-flop. When the pushbutton input does not equal the internal debounced button state (the Q output of the D flip-flop), the XNOR gate issues a counter reset. When the switch input state is stable for the full qualification period, the counter clocks the D flip-flop, changing the internal pushbutton state. The Q output of the D flip-flop is connected to a toggle flip-flop that toggles when the internal pushbutton state goes through a high-to-low transition. Figure 1 shows the typical opening and closing switch debounce operation.

A rising pulse at CLEAR resets the T flip-flop and pulls OUT low and OUT high.

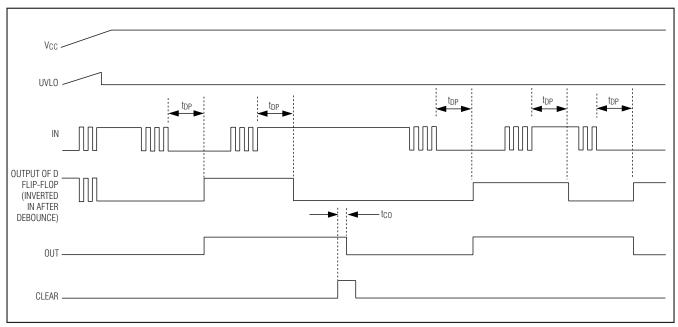


Figure 1. MAX16054 Timing Diagram

#### **Undervoltage Lockout**

The undervoltage-lockout circuitry ensures that the outputs are at the correct state on power-up. While  $V_{CC}$  is less than the 2.1V (typ) undervoltage threshold and greater than 1.0V, OUT remains low and transitions at IN are ignored.

#### **Robust Switch Input**

The switch input (IN) has overvoltage clamping diodes to protect against damaging fault conditions. Switch input voltages can safely swing ±25V to ground. Proprietary ESD-protection structures protect against high ESD encountered in harsh industrial environments, membrane keypads, and portable applications. They are designed to withstand ±15kV per the IEC 61000-4-2 Air-Gap Discharge test and ±8kV per the IEC 61000-4-2 Contact-Discharge test.

Since there is a  $63k\Omega$  (typ) pullup resistor connected to IN, driving the input to -25V draws approximately 0.5mA from the V<sub>CC</sub> supply. Driving the input to +25V causes approximately 0.32mA of current to flow back into the V<sub>CC</sub> supply. If the total system V<sub>CC</sub> supply current is less than the current flowing back into the V<sub>CC</sub> supply,

V<sub>CC</sub> rises above normal levels. In some low-current systems, a zener diode on V<sub>CC</sub> may be required.

#### ±15kV ESD Protection

ESD-protection structures are incorporated on all pins to protect against electrostatic discharges encountered during handling and assembly. The MAX16054 has extra protection against static electricity to protect against ESD of ±15kV at the switch input without damage. The ESD structures withstand high ESD in all states: normal operation, shutdown, and powered down. A design advantage of the MAX16054 is that it continues working without latchup after an ESD event, which eliminates the need to power-cycle the device.

ESD protection can be tested in various ways; this product is characterized for protection to the following limits:

- 1) ±15kV using the Human Body Model.
- 2) ±8kV using the Contact-Discharge method specified in IEC 61000-4-2.
- 3) ±15kV using the IEC 61000-4-2 Air-Gap method.

#### **Human Body Model**

Figure 2a shows the Human Body Model, and Figure 2b shows the current waveform it generates when discharged into a low impedance. This model consists of a 100pF capacitor charged to the ESD voltage of interest, which is then discharged into the test device through a  $1.5 \mathrm{k}\Omega$  resistor.

#### IEC 61000-4-2

The IEC 61000-4-2 standard covers ESD testing and performance of finished equipment; it does not specifically refer to integrated circuits. The MAX16054 helps in the design of equipment that meets IEC 61000-4-2, without the need for additional ESD-protection components.

The major difference between tests done using the Human Body Model and IEC 61000-4-2 is higher peak current in IEC 61000-4-2, because series resistance is

 $R_{\mathbb{C}}$  $R_D$  1500 $\Omega$ CHARGE-CURRENT DISCHARGE RESISTANCE LIMIT RESISTOR HIGH-DEVICE  $\mathsf{C}_\mathsf{S}$ STORAGE **VOLTAGE** UNDER 100pF CAPACITOR DC TEST SOURCE

Figure 2a. Human Body ESD Test Model

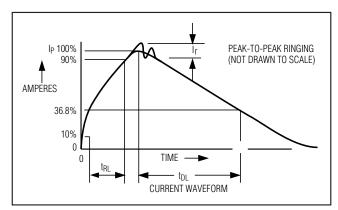


Figure 2b. Human Body Current Waveform

lower in the IEC 61000-4-2 model. Hence, the ESD withstand voltage measured to IEC 61000-4-2 is generally lower than that measured using the Human Body Model. Figure 3a shows the IEC 61000-4-2 model, and Figure 3b shows the current waveform for the IEC 61000-4-2 ESD Contact-Discharge test.

The Air-Gap test involves approaching the device with a charged probe. The Contact-Discharge method connects the probe to the device before the probe is energized.

#### Machine Model

The Machine Model for ESD tests all pins using a 200pF storage capacitor and zero discharge resistance. Its objective is to emulate the stress caused by contact that occurs with handling and assembly during manufacturing.

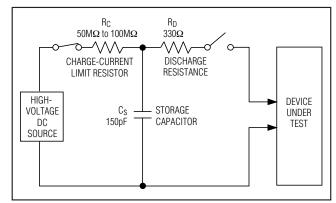


Figure 3a. IEC 61000-4-2 ESD Test Model

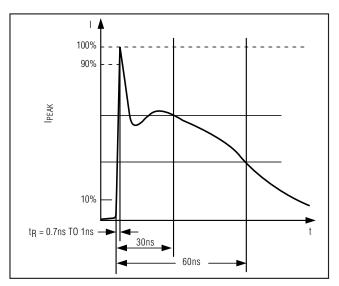
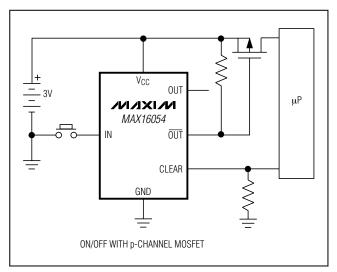
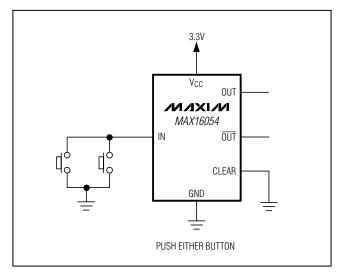
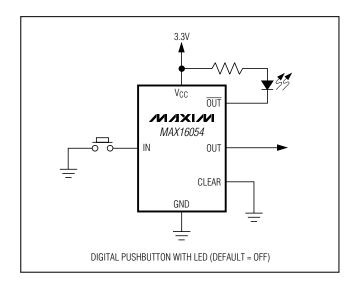


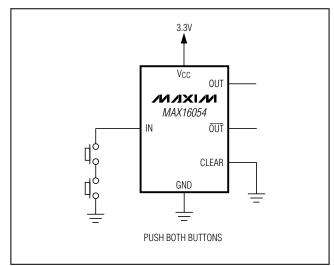
Figure 3b. IEC 61000-4-2 ESD Generator Current Waveform

## **Typical Operating Circuits (continued)**

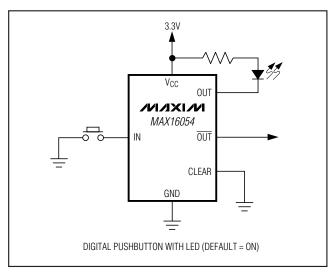


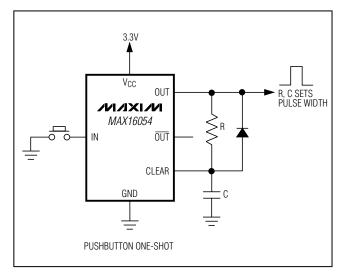


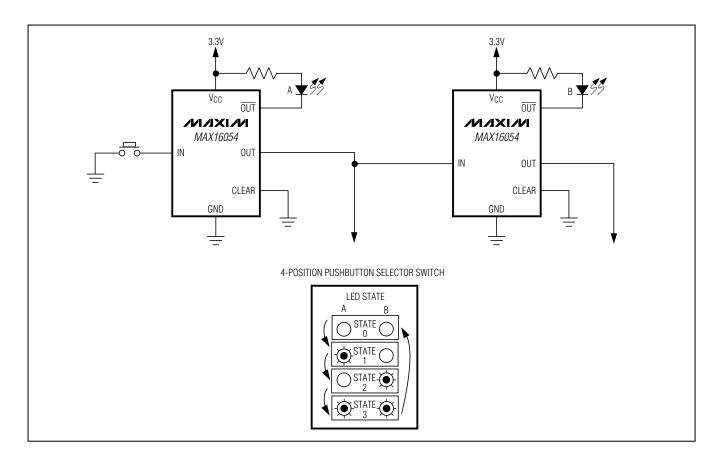




## **Typical Operating Circuits (continued)**







# MAX16054

# On/Off Controller with Debounce and ±15kV ESD Protection

**Chip Information** 

PROCESS: BiCMOS

#### **Package Information**

For the latest package outline information, go to <a href="https://www.maxim-ic.com/packages">www.maxim-ic.com/packages</a>.

PACKAGE TYPE	PACKAGE CODE	DOCUMENT NO.
6 Thin SOT23	Z6-1	<u>21-0114</u>

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